Search Notes			

Application/Control No.	Applicant(s)/Patent under Reexamination
10/679,771	HAN ET AL.
Examiner	Art Unit
Richard H. Kim	2871

SEARCHED			
Class	Subclass	Date	Examiner

INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner
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SEARCH NO (INCLUDING SEARCI		)
	DATE	EXMR
No additional search required	8/18/2006	RHK
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